

• Product Summary

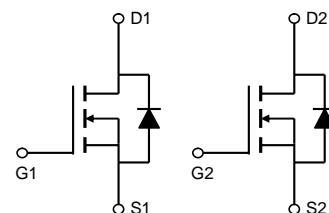
Part #	V _{DS}	R _{DS(on).typ} (@V _{GS} =10V)	R _{DS(on).typ} (@V _{GS} =4.5V)	I _D
EFM6802L2X	30V	31mΩ	40mΩ	3.5A

• Description

- The EFM6802L2X is the high cell density trenched
- DualN-ch MOSFETs which provide excellent
- RDSON and gate charge for most of the
- synchronous buck converter applications.
- The EFM6802L2X meet the RoHS and Green
- Product requirement, 100 % EAS guaranteed
- with full function reliability approved.

• Application

- Super Low Gate Charge 100% EAS Guaranteed
- Green Device Available Excellent CdV/dt effect decline
- Advanced high cell density Trench technology


Dual N-Channel MOSFET

SOT-23-6L

• Ordering Information:

Part NO.	EFM6802L2X
Marking	H2****
Packing Information	REEL TAPE
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings (T_C=25°C)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current-Continuous	I _D	3.5	A
Drain Current-Pulsed ^(Note 1)	I _{DM}	20	A
Maximum Power Dissipation	P _D	1.2	W
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 To 150	°C

• Thermal Characteristic

Thermal Resistance, Junction-to-Ambient ^(Note 2)	R _{θJA}	110	°C/W
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• Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)

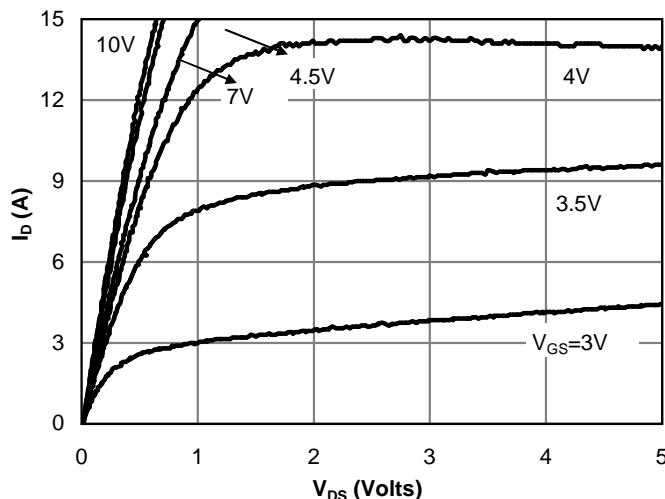
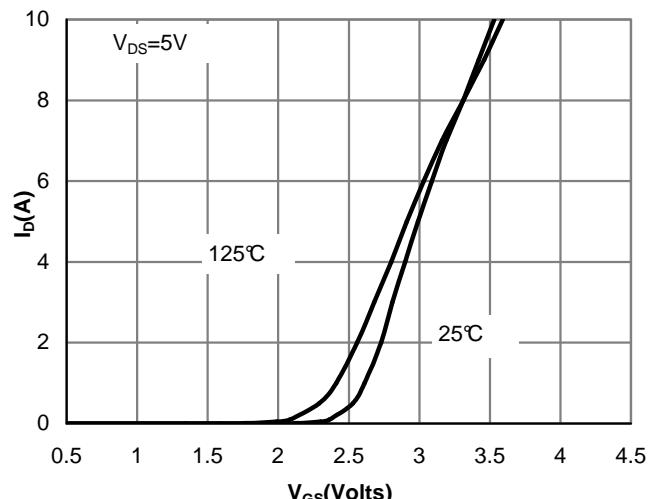
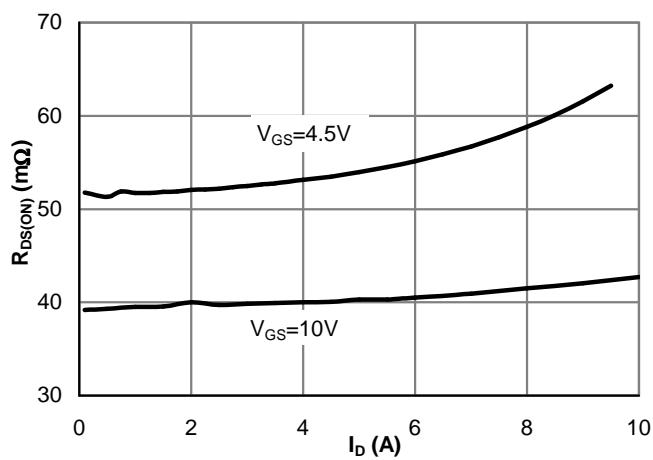
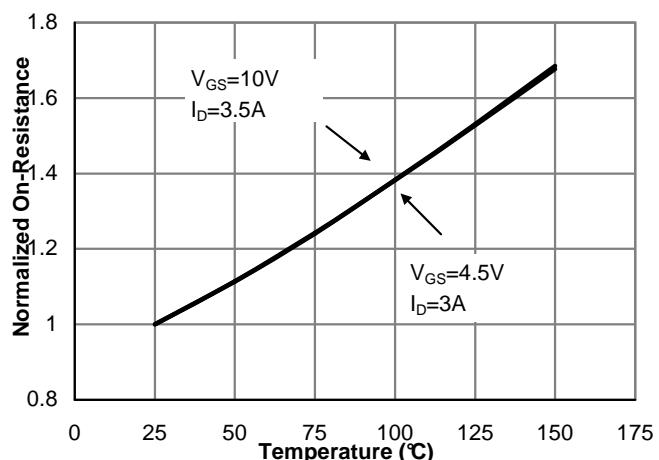
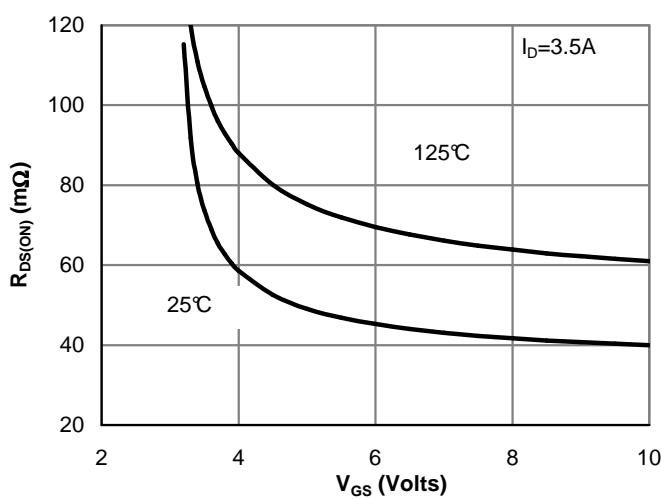
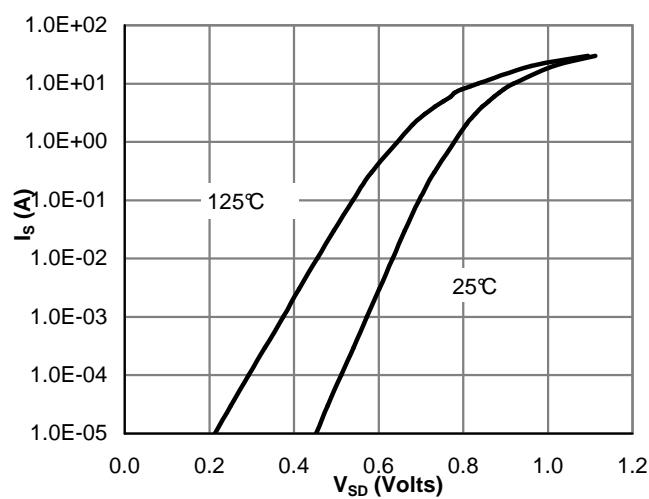
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V} I_{\text{D}}=250\mu\text{A}$	30	--	--	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}}=30\text{V} V_{\text{GS}}=0\text{V}$	--	--	1	μA
Gate-Body Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V} V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
On Characteristics <small>(Note 3)</small>						
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{DS}}=V_{\text{GS}} I_{\text{D}}=250\mu\text{A}$	1.0	1.5	2.5	V
Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V} I_{\text{D}}=3.5\text{A}$	--	31	42	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V} I_{\text{D}}=3\text{A}$	--	40	50	$\text{m}\Omega$
Forward Transconductance	g_{FS}	$V_{\text{DS}}=5\text{V} I_{\text{D}}=3.5\text{A}$	--	12	--	S

Dynamic Characteristics <small>(Note 4)</small>						
Input Capacitance	C_{iss}	$V_{\text{DS}}=15\text{V} V_{\text{GS}}=0\text{V}$ $F=1.0\text{MHz}$	--	170	--	PF
Output Capacitance	C_{oss}		--	35	--	PF
Reverse Transfer Capacitance	C_{rss}		--	23	--	PF
Switching Characteristics <small>(Note 4)</small>						
Turn-on Delay Time	$t_{\text{d(on)}}$	$V_{\text{DD}}=15\text{V} I_{\text{D}}=3.5\text{A}$ $V_{\text{GS}}=10\text{V} R_{\text{G}}=3\Omega$	--	4.5	--	nS
Turn-on Rise Time	t_r		--	1.5	--	nS
Turn-Off Delay Time	$t_{\text{d(off)}}$		--	18.5	--	nS
Turn-Off Fall Time	t_f		--	15.5	--	nS
Total Gate Charge	Q_g	$V_{\text{DS}}=15\text{V} I_{\text{D}}=3.5\text{A}$ $V_{\text{GS}}=10\text{V}$	--	4	--	nC
Gate-Source Charge	Q_{gs}		--	0.55	--	nC
Gate-Drain Charge	Q_{gd}		--	1	--	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage <small>(Note 3)</small>	V_{SD}	$V_{\text{GS}}=0\text{V} I_{\text{S}}=3.5\text{A}$	--	0.75	1.2	V
Diode Forward Current <small>(Note 2)</small>	I_{S}		--	--	3.5	A

Notes:

a. Surface Mounted on FR4 Board , $T < 10 \text{ sec}$;

• Typical Characteristics


Fig 1: On-Region Characteristics (Note E)

Figure 2: Transfer Characteristics (Note E)

Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

Figure 4: On-Resistance vs. Junction Temperature (Note E)

Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

Figure 6: Body-Diode Characteristics (Note E)

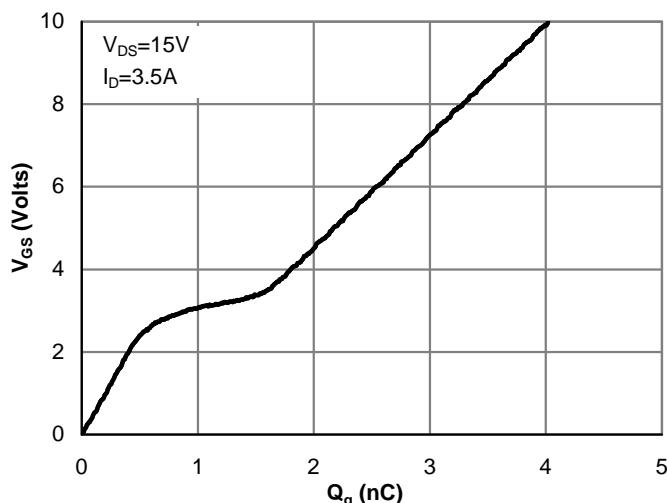


Figure 7: Gate-Charge Characteristics

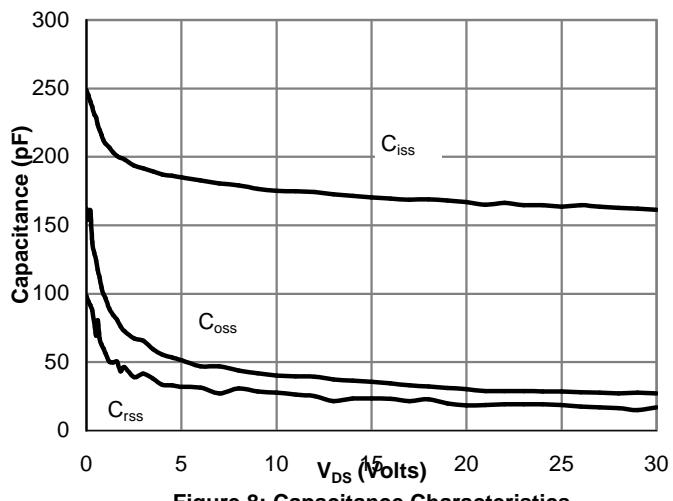


Figure 8: Capacitance Characteristics

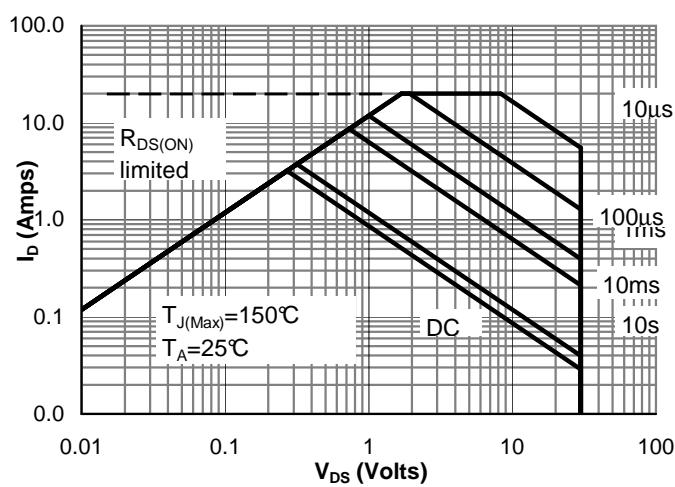


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

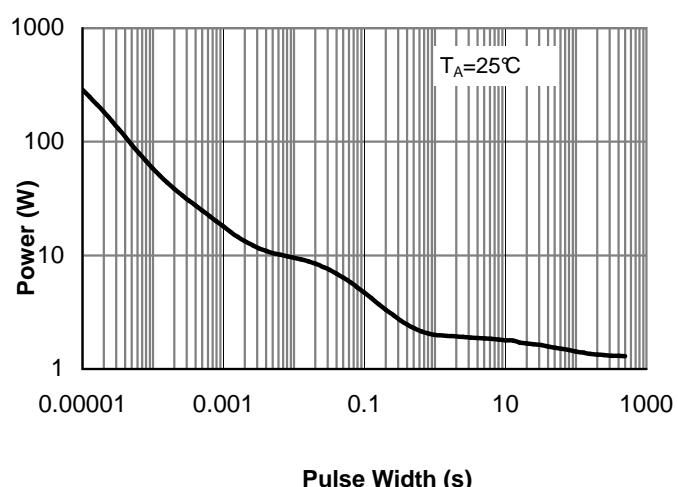
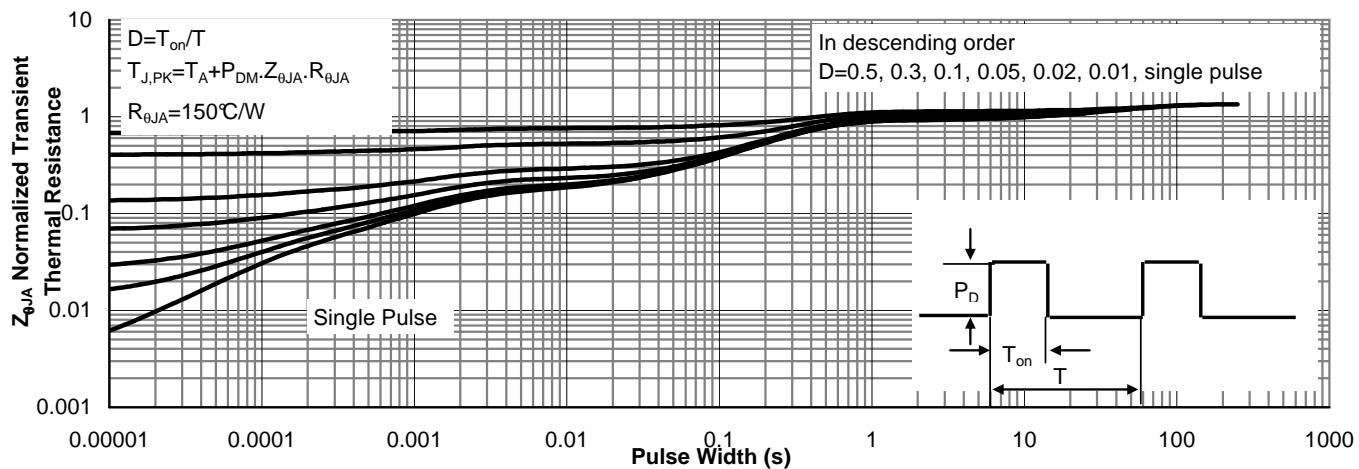
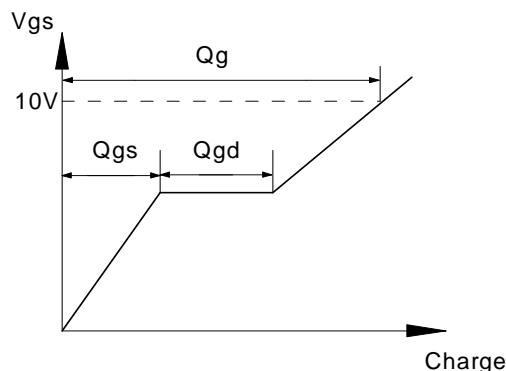
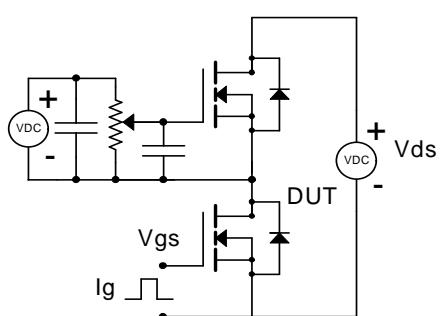

 Figure 10: Single Pulse Power Rating
 Junction-to-Ambient (Note F)


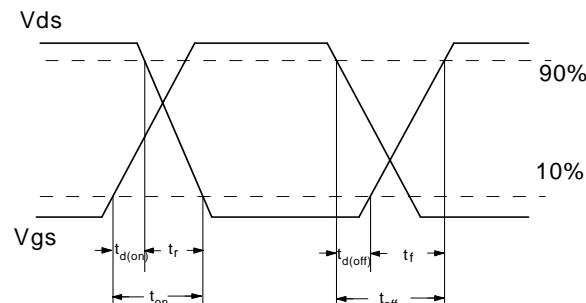
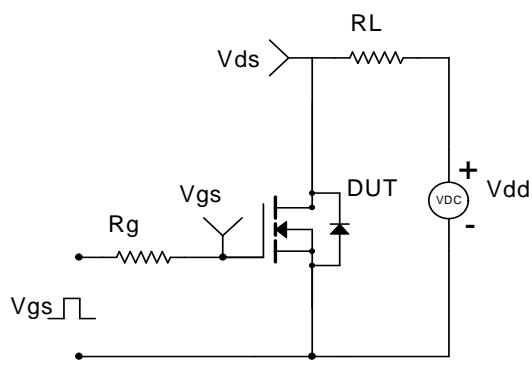
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

• Test circuit

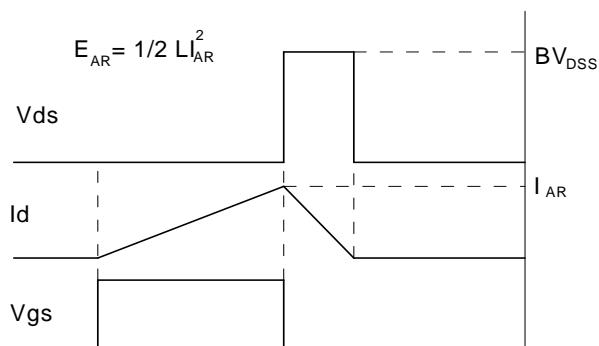
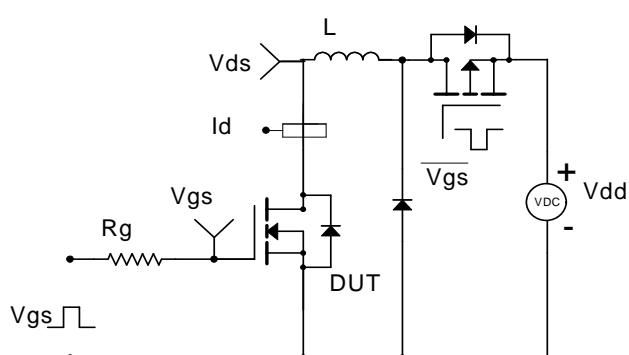
Gate Charge Test Circuit & Waveform



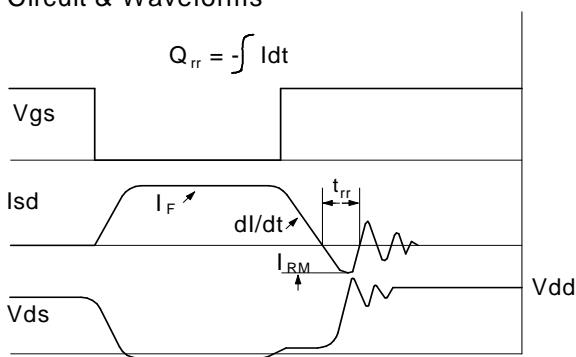
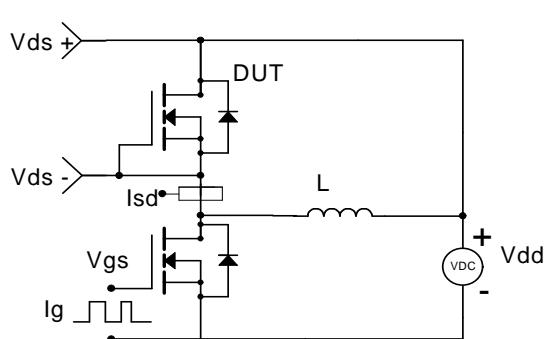
Resistive Switching Test Circuit & Waveforms

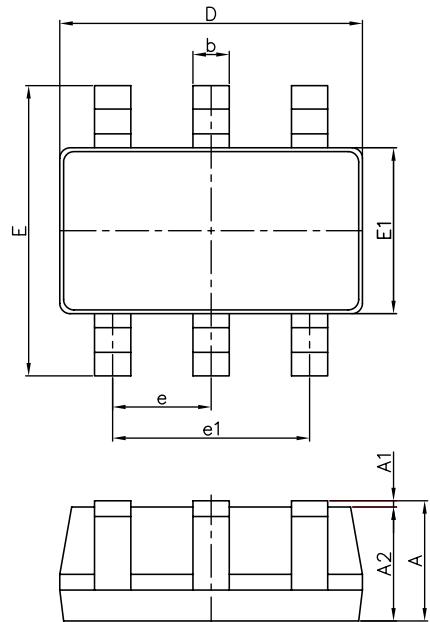


Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

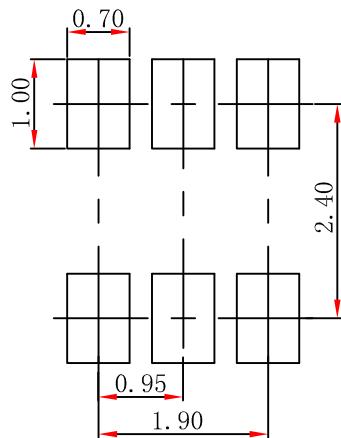


Diode Recovery Test Circuit & Waveforms



SOT-23-6L Package Outline Dimensions


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°


Note:

1. Controlling dimension: in millimeters.
2. General tolerance: $\pm 0.05\text{mm}$.
3. The pad layout is for reference purposes only.